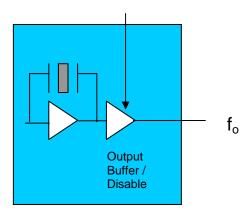


VCE1 series 3.3, 5.0 volt CMOS Oscillator



The VCE1 Crystal Oscillator



Features

- CMOS output
- Output frequencies to 66.667 MHz
- · Tri-state output for board test and debug
- 0/70 or -40/85 °C operating temperature
- Low cost industry standard 14x9.8 mm package
- RoHS and lead free compliant construction

Applications

- SONET/SDH/DWDM
- Ethernet, Gigabit Ethernet
- Storage Area Network
- Digital Video
- Broadband Access
- Microprocessors/DSP/FPGA

Description

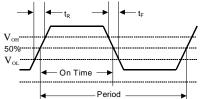
Vectron's VCE1 Crystal Oscillator (XO) is quartz stabilized square wave generator with a CMOS output, operating off a 3.3 or 5.0 volt supply.

Performance Characteristics

Table 1. Electrical Performance, 5V option					
Parameter	Symbol	Min	Typical	Maximum	Units
Frequency	f _O	1.000		66.667	MHz
Operating Supply Voltage ¹	V_{DD}	4.5	5.0	5.5	V
Absolute Maximum Supply Voltage		-0.7		7.0	V
Supply Current, Output Enabled	I _{DD}			40	mΑ
Output Logic Levels					
Output Logic High ²	V_{OH}	$0.9*V_{DD}$			V
Output Logic Low ²	V _{OL}			0.1*V _{DD}	V
Output Rise/Fall Time ²	t _{R/} t _F			8	ns
Duty Cycle ³ (ordering option)	SYM	40/60 or 45/55		%	
Operating Temperature (ordering option)	T _{OP}		0/70 or -40/85	5	°C
Storage Temperature	T _{STOR}	-55		125	°C
Stability ⁴ (ordering option)	ΔF/T	±50, ±100		ppm	
Output Enable/Disable ⁵	E/D				V
Output Enabled		4.0			
Output Disabled				0.8	
Start-up time	T _{SU}			10	ms

Table 2. Electrical Performance, 3.3V option					
Parameter	Symbol	Min	Typical	Maximum	Units
Frequency	f _O	1.000		66.667	MHz
Operating Supply Voltage ¹	V_{DD}	2.97	3.3	3.63	V
Absolute Maximum Operating Voltage		-0.5		5.0	V
Supply Current, Output Enabled	I _{DD}			40	mΑ
Output Logic Levels					
Output Logic High ²	V_{OH}	$0.9*V_{DD}$			V
Output Logic Low ²	V_{OL}			0.1*V _{DD}	V
Output Rise/Fall Time ²	t _{R/} t _F			8	ns
Duty Cycle ³ (ordering option)	SYM	40/60 or 45/55		%	
Operating Temperature (ordering option)	T _{OP}		0/70 or -40/8	5	°C
Storage Temperature	T _{STOR}	-55		125	°C
Stability ⁴ (ordering option)	ΔF/T	±50, ±100		ppm	
Output Enable/Disable ⁵	E/D				V
Output Enabled		2.0			
Output Disabled				0.5	
Start-up time	T_{SU}		l	10	ms

- 1. A 0.01uF and a 0.1uF capacitor should be located as close to the supply as possible (to ground) is recommended.
- 2. Figure 3 defines these parameters. Figure 4 illustrates the operating conditions under which these parameters are tested and specified. For Fo>90MHz, rise and fall time is measured 20 to 80%.
- 3. Symmetry is measured defined as On Time/Period.
- 4. Includes calibration tolerance, operating temperature, supply voltage variations, aging and shock and vibration.
- 5. Output will be enabled if enable/disable is left open.



 V_{DD} + .1 μF = .01 μF = $\frac{4}{1}$ $\frac{3}{15pF}$ =

Figure 3. Output Waveform

Figure 4. Typical Output Test Conditions (25±5°C)

Enable/Disable Functional Description

Under normal operation the Enable/Disable is left open or set to a logic high state. When the E/D is set to a logic low, the oscillator stops and the output is in a high impedance state. This helps reduce power consumption as well as facilitating board testing and troubleshooting.

Tri-state Functional Description

Under normal operation the tri-state is left open or set to a logic high state. When the tri-state is set to a logic low, the oscillator remains active but the output buffer is in a high impedance state. This helps facilitate board testing and troubleshooting.

Table 3. Outline Diagrams and Pin Out

Pin #	Symbol	Function	
1	E/D or NC	Tri-state, Enable/Disable or NC	
2	GND	Electrical and Case Ground	
3	f _O	Output Frequency	
4	V _{DD}	Supply Voltage	

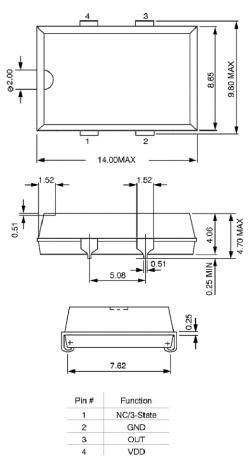


Figure 5, Package drawing

Reliability

The VCE1 qualification tests have included:

Table 4. Environnemental Compliance				
Parameter	Conditions			
Mechanical Shock	MIL-STD-883 Method 2022			
Mechanical Vibration	MIL-STD-883 Method 2007			
Temperature Cycle	MIL-STD-883 Method 1010			
Gross and Fine Leak	MIL-STD-883 Method 1014			
Resistance to Solvents	MIL-STD-883 Method 2015			

Handling Precautions

Although ESD protection circuitry has been designed into the the VCE1, proper precautions should be taken when handling and mounting. VI employs a Human Body Model and a Charged-Device Model (CDM) for ESD susceptibility testing and design protection evaluation. ESD thresholds are dependent on the circuit parameters used to define the model. Although no industry wide standard has been adopted for the CDM, a standard HBM of resistance = 1.5kohms and capacitance = 100pF is widely used and therefore can be used for comparison purposes.

Table 5. ESD Ratings					
Model	Minimum	Conditions			
Human Body Model	1000	MIL-STD-883 Method 3115			
Charged Device Model	1500	JESD 22-C101			

Suggested IR profile

Devices are built using lead free epoxy, but are only rated for a maximum 240°C reflow. A typical reflow profile is shown below in Figure 6.

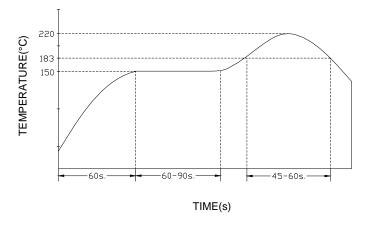
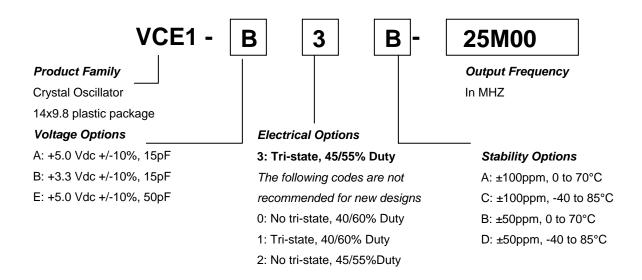


Figure 6. Suggested Reflow Profile

Ordering Information:



Note: Not all combinations are available.

Tri-state with a 45/55% is the most common Electrical code and is recommended for most applications.

Devices will be shipped in Anti Static Tubes

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